Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/736,720	LEE, KEUN WOO	
Examiner	Art Unit	
Fric B Chen	1765	

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Class	Subclass	Date	Examiner		
	,				

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Class	Subclass	Date	Examiner
	<u>.                                    </u>		
PB-PUB to	ext search	12/3/2005	EC

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Inventor search (UPDATED)	12/3/2005	EC
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438/221,296,427,637,369,370,690- 692,700,702,706,710,719,723,724, 745,753,756,757,770,775 (text search only) (UPDATED)	12/3/2005	EC